

MOSFET

IR MOSFET - StrongIRFET™

Benefits

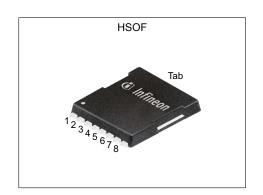
- Improved Gate and Avalanche Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Improved I_D rating
 Pb-Free ; RoHS Compliant ; Halogen-Free

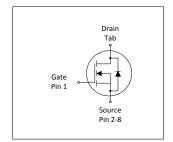
Potential applications

- Brushed Motor drive applications
- BLDC Motor drive applications
- · Battery powered circuits
- Half-bridge and full-bridge topologies
- Synchronous rectifier applications
- Resonant mode power supplies
- OR-ing and redundant power switches
 DC/DC and AC/DC converters
 DC/AC Inverters



Parameter	Value	Unit
V _{DS}	40	V
$R_{\mathrm{DS(on),typ}}$	0.59	mΩ
$R_{\mathrm{DS(on),max}}$	0.72	mΩ
I _D (Silicon Limited)	586	A
I _{D (Package Limited)}	300	A











Type / Ordering Code	Package	Marking	Related Links
IRL40T209	PG-HSOF-8	RL40T209	-

IR MOSFET - StrongIRFET™ IRL40T209



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1 Maximum ratings at TC=25 °C, unless otherwise specified

Table 2 **Maximum ratings**

Davamatan	Ols al	Values				N
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current	I _D			300 586 347	A	$V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C $V_{\rm GS}$ =10 V, $T_{\rm C}$ =25 °C (silicon limited) $V_{\rm GS}$ =10 V, $T_{\rm C}$ =100 °C (silicon limited) ¹⁾
Pulsed drain current ¹⁾	I _{D,pulse}	-	-	1200	Α	<i>T</i> _C =25 °C
Avalanche energy, single pulse ²⁾	E AS	-	-	875	mJ	$I_{\rm D}$ =100 A, $R_{\rm GS}$ =50 Ω
Gate source voltage	V _{GS}	-20	-	20	V	-
Power dissipation	P _{tot}	-	-	500	W	<i>T</i> _C =25 °C
Operating and storage temperature	T _j , T _{stg}	-55	-	175	°C	IEC climatic category; DIN IEC 68-1 55/175/56

2 **Thermal characteristics**

Table 3 **Thermal characteristics**

Dovomotor	Symbol	Values			l lmi4	Note / Took Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Thermal resistance, junction - case, bottom ³⁾	R _{thJC}	-	-	0.3	°C/W	-
Thermal resistance, junction - case, top	R _{thJC}	-	-	20	°C/W	-
Device on PCB, 6 cm² cooling area ¹⁾	R _{thJA}	-	-	30	°C/W	-
Device on PCB, RTHJA(<10s)	R _{thJA}	-	-	12	°C/W	-

 $^{^{1)}}$ See Diagram 3 for more detailed information $^{2)}$ See Diagram 13 for more detailed information $^{3)}$ R_{thJC} is measured at T_{J} approximately 90°C.

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3 Electrical characteristics at T_j =25 °C, unless otherwise specified

Table 4 **Static characteristics**

Donomotor	O. was book	Values			11		
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Drain-source breakdown voltage	V _{(BR)DSS}	40	-	-	V	V _{GS} =0 V, I _D =250 μA	
Breakdown voltage temperature coefficient	$dV_{(BR)DSS}/dT_{j}$	-	31	-	mV/°C	I _D =5 mA, referenced to 25 °C	
Gate threshold voltage	$V_{\mathrm{GS(th)}}$	1	-	2.4	V	V _{DS} =V _{GS} , I _D =250 μA	
Zero gate voltage drain current	I _{DSS}	-	-	1 150	μΑ	V _{DS} =40 V, V _{GS} =0 V, T _j =25 °C V _{DS} =40 V, V _{GS} =0 V, T _j =125 °C	
Gate-source leakage current	I _{GSS}	-	-	100	nA	V _{GS} =20 V, V _{DS} =0 V	
Drain-source on-state resistance	R _{DS(on)}	-	0.59 0.75	0.72 1.10	mΩ	V _{GS} =10 V, I _D =100 A V _{GS} =4.5 V, I _D =50 A	
Gate resistance ¹⁾	R _G	-	2.0	-	Ω	-	
Transconductance	g fs	-	380	-	S	$ V_{DS} \ge 2 I_D R_{DS(on)max}, I_D = 100 A$	

Table 5 **Dynamic characteristics**

Dougnator	Ob. a.l	Values			1124	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance ¹⁾	C _{iss}	-	16000	-	pF	V _{GS} =0 V, V _{DS} =20 V, <i>f</i> =1 MHz
Output capacitance ¹⁾	Coss	-	2200	-	pF	V _{GS} =0 V, V _{DS} =20 V, f=1 MHz
Reverse transfer capacitance ¹⁾	C _{rss}	-	1600	-	pF	V _{GS} =0 V, V _{DS} =20 V, f=1 MHz
Turn-on delay time	$t_{ m d(on)}$	-	60	-	ns	$V_{\rm DD}$ =20 V, $V_{\rm GS}$ =4.5 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =2.7 Ω
Rise time	t _r	-	230	-	ns	$V_{\rm DD}$ =20 V, $V_{\rm GS}$ =4.5 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =2.7 Ω
Turn-off delay time	$t_{ m d(off)}$	-	190	-	ns	$V_{\rm DD}$ =20 V, $V_{\rm GS}$ =4.5 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =2.7 Ω
Fall time	t _f	-	160	-	ns	$V_{\rm DD}$ =20 V, $V_{\rm GS}$ =4.5 V, $I_{\rm D}$ =30 A, $R_{\rm G,ext}$ =2.7 Ω

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Gate charge characteristics¹⁾ Table 6

Parameter	Cumbal	Values			11:4	Nata / Tast Canditian
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q _{gs}	-	43	-	nC	V_{DD} =20 V, I_{D} =100 A, V_{GS} =0 to 4.5 V
Gate charge at threshold	$Q_{g(th)}$	-	26	-	nC	V_{DD} =20 V, I_{D} =100 A, V_{GS} =0 to 4.5 V
Gate to drain charge ²⁾	Q _{gd}	-	83	-	nC	V_{DD} =20 V, I_{D} =100 A, V_{GS} =0 to 4.5 V
Switching charge	Q _{sw}	-	100	-	nC	V_{DD} =20 V, I_{D} =100 A, V_{GS} =0 to 4.5 V
Gate charge total ²⁾	Qg	-	179	269	nC	V_{DD} =20 V, I_{D} =100 A, V_{GS} =0 to 4.5 V
Gate plateau voltage	V _{plateau}	-	2.6	-	V	V_{DD} =20 V, I_{D} =100 A, V_{GS} =0 to 4.5 V
Gate charge total, sync. FET	Q _{g(sync)}	-	96	-	nC	V _{DS} =0.1 V, V _{GS} =0 to 4.5 V
Output charge ¹⁾	Qoss	-	84	-	nC	V _{DD} =20 V, V _{GS} =0 V

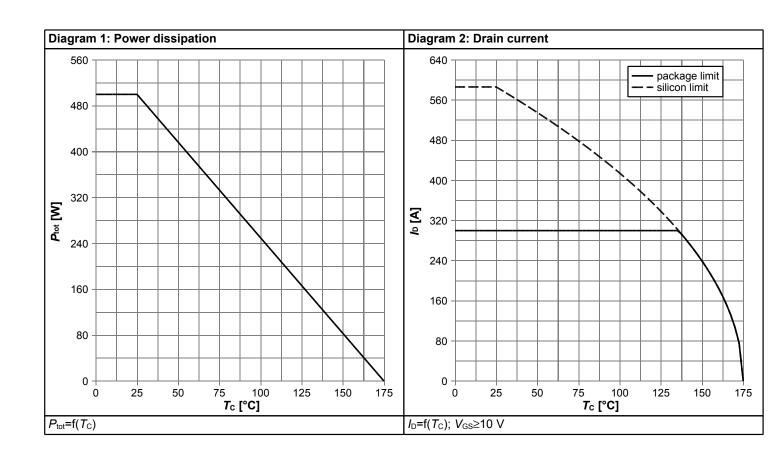
Table 7 Reverse diode

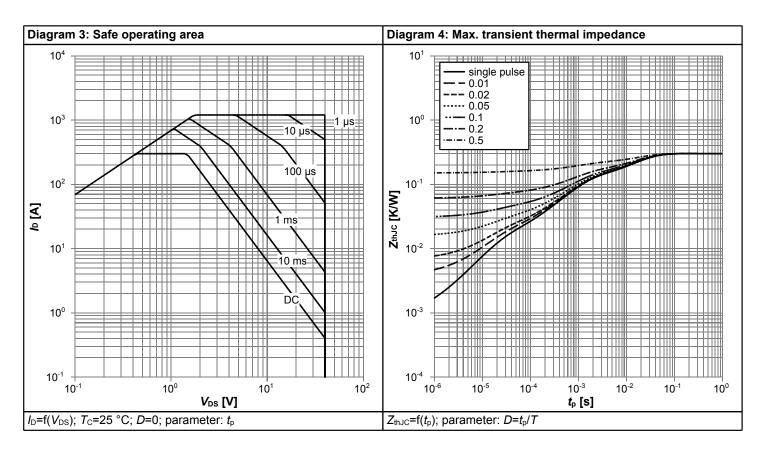
Damamatan	Cumbal	Values			I I m i4	Nata / Tast Candition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode continuous forward current ³⁾	Is	-	-	300	Α	T _C =25 °C
Diode pulse current	I S,pulse	-	-	1200	Α	T _C =25 °C
Diode forward voltage	V _{SD}	-	-	1.2	V	V _{GS} =0 V, I _F =100 A, T _j =25 °C
Reverse recovery time ²⁾	t _{rr}	-	52	-	ns	V_R =34 V, I_F =100 A, di_F/dt =100 A/ μ s, Tj=25 °C
Reverse recovery charge ²⁾	Qrr	-	79	-	nC	V _R =34 V, I _F =100 A, d <i>i</i> _F /d <i>t</i> =100 A/μs, Tj=25 °C

 $^{^{1)}}$ See "Gate charge waveforms" for parameter definition $^{2)}$ Defined by design. Not subject to production test. $^{3)}$ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

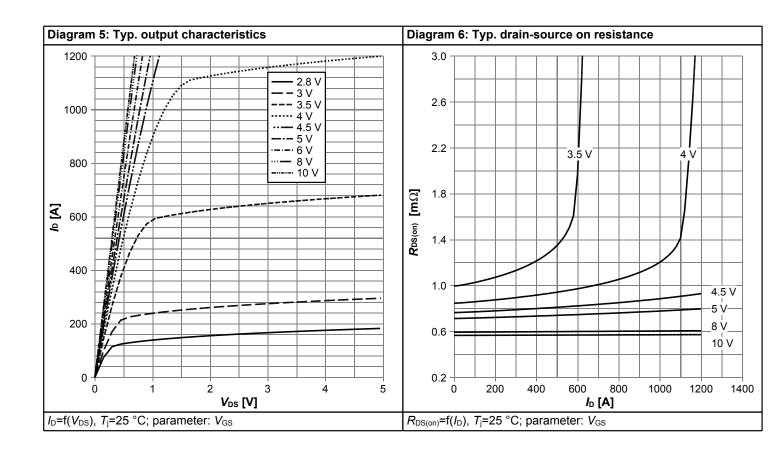


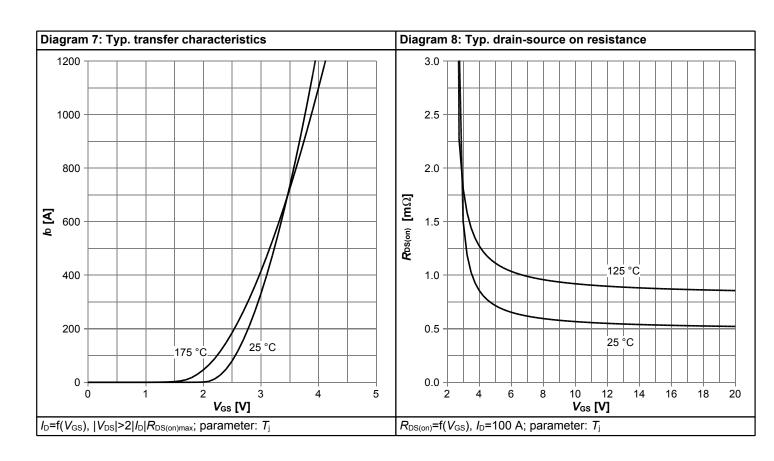
4 Electrical characteristics diagrams



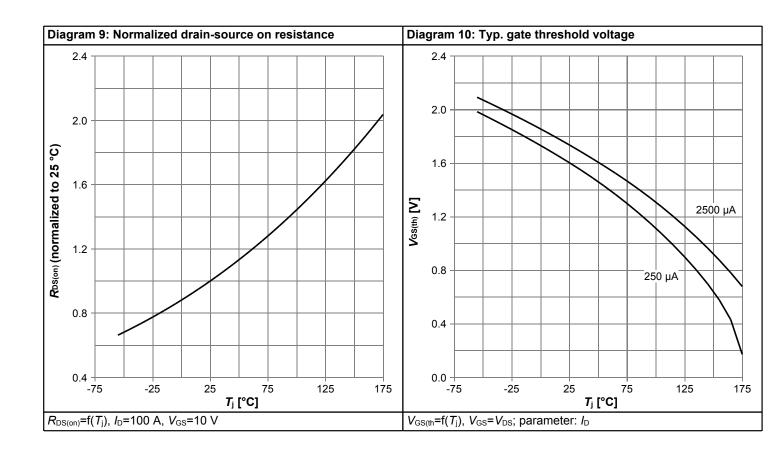


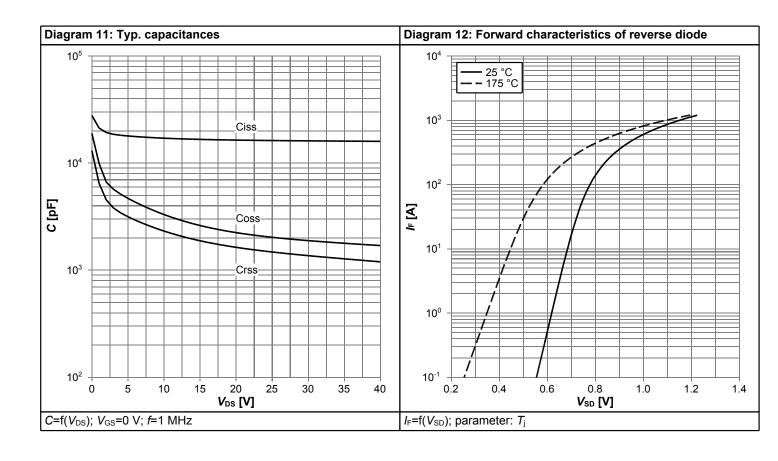




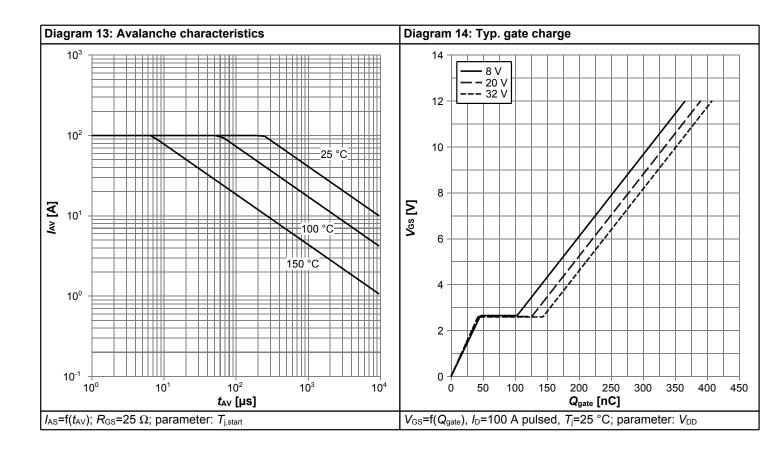


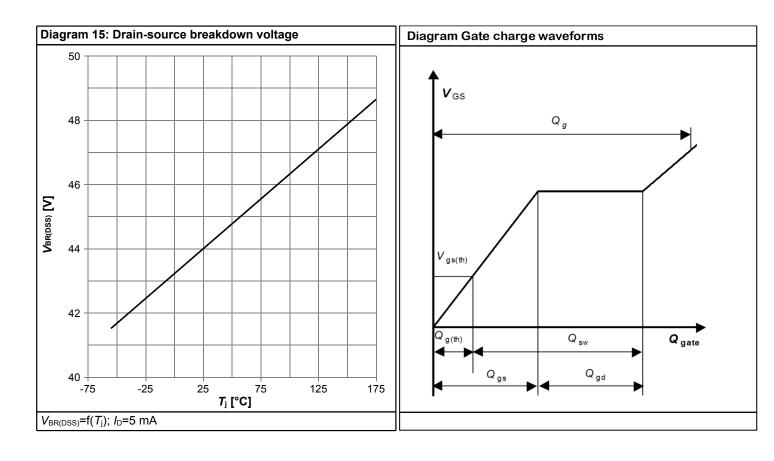














5 Package Outlines

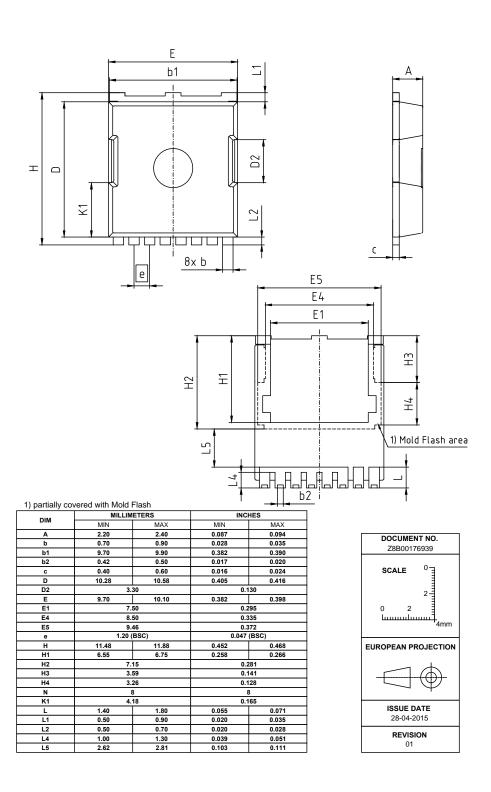


Figure 1 Outline PG-HSOF-8, dimensions in mm/inches

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IRL40T209



Revision History

IRL40T209

Revision: 2018-05-05, Rev. 2.0

Previous Revision

Revision	Date	Subjects (major changes since last revision)
1.0	2018-04-24	Release of preliminary version
2.0	2018-05-05	Release of final version

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